EMP III

Evaluating the
Measurement Process
&
Using Imperfect Data

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Contents

	Abc	out the Author	xiii
	Acknowledgments		xiv
Prefac		ace	xυ
	Pref	ace to the Second Printing	xvi
Chapter 1	Frequently Asked Questions		1
	1.1	Questions Regarding Measurements	1
	1.2	Four Ways We Use Measurements	3
	1.3	A Model for Measurements	5
	1.4	Observational Studies versus Experimental Studies	7
	1.5	The Organization of This Book	9
PART ONE	: CF	HARACTERIZING THE MEASUREMENT PROCESS	
Chapter 2	Con	sistency Charts	11
	2.1	Two Technicians	11
	2.2	An Operational Definition of Measurement Consistency	13
	2.3	Which Comes First? The Chart or the Adjustment?	15
	2.4	Measurement Consistency for Destructive Tests	18
	2.5	Rubber Rulers	19
	2.6	Rubber Parts	21
	2.7	Consistency Charts for Subjective Values	21
	2.8	Summary for Consistency Charts	22
Chapter 3	Pred	cision	23
	3.1	Quantifying Precision with the Estimated Standard Deviation	23
	3.2	Quantifying Precision with the Probable Error	25
	3.3	Manufacturing Specifications	30
	3.4	Summary for Consistency Charts	33
Chapter 4	Bias		35
_	4.1	All Bias is Relative	35
	4.2	But Do I Have to Do the Graph?	39
	4.3	Consistency of Bias	42
	4.4	Comparing Two Procedures for Relative Bias	43
	4.5	Summary for Part One: Characterizing a Measurement System	45

PART TWO: EVALUATING THE MEASUREMENT PROCESS

Chapter 5	Relative Utility and Short EMP Studies		47
	5.1	The Intraclass Correlation Coefficient	47
	5.2	Relative Utility Using Consistency Charts and Product Charts	49
	5.3	Four Classes of Process Monitors	52
	5.4	A Note on Notation for Measurement Error	54
	5.5	Short EMP Studies	55
	5.6	Measurement Systems That Use Multiple Determinations	59
	5.7	Summary	64
		Worksheet for Short EMP Study	66
Chapter 6	Bas	sic EMP Studies:	
	Ide	ntifying Nuisance Components of Measurement Error	67
	6.1	Basic EMP Studies and Potential Nuisance Components	67
	6.2	Checking for Detectable Bias: Main Effect Charts	73
	6.3	Checking for Differences in Test-Retest Error	78
	6.4	What to Look For in an EMP Study	84
	6.5	Discrimination Ratios and Intraclass Correlation Plots	88
	6.6	Summary of Basic EMP Studies	90
Chapter 7	Son	ne Basic EMP Studies	91
	7.1	EMP Study Number 33	91
	7.2	An EMP Study for Truck Spoke Dimension No. 2	94
	7.3	An EMP Study for the Compression Test	96
	7.4	An EMP Study for the Nanometric Gauge	101
	7.5	The Manual Test Stand for Product T143	103
	7.6	A Round-Robin Study for Silica-Producing Volatiles	106
	7.7	Summary	112
Chapter 8	Two-Factor EMP Studies		113
	8.1	Test Method 623 with Product 1108	113
	8.2	Test Method 623 with Product 1108 in a Nested Study	117
	8.3	A Nested Study for Test Method 623 with Product 1402	120
	8.4	Summary	126

PART THREE: USING IMPERFECT DATA

Chapter 9	Chunky Data or Inadequate Measurement Increments	
	9.1 Chunky Data	127
	9.2 Fixing Chunky Data	131
	9.3 The Detection Rules for Chunky Data	133
	9.4 Will the Standard Deviation Statistic Fix Chunky Data?	136
	9.5 Chunky Data in an EMP Study	138
	9.6 Summary	138
Chapter 10	Censored Data	139
	10.1 Assays for Compound M	139
	10.2 Life Testing	146
	10.3 Compound Y	147
Chapter 11	Characterizing the Product Not Measured	149
	11.1 The Problem of Representation	149
	11.2 The Lot Fraction Nonconforming	150
	11.3 Acceptance Sampling	152
	11.4 Within-Batch Uniformity for Measured Properties	156
	11.5 Batch-to-Batch Uniformity and Grand Lots	159
	11.6 Quality Assurance with Count Data	161
	11.7 Grand Lots versus Acceptance Sampling	162
	11.8 Summary	164
Chapter 12	Prediction	165
	12.1 The Process Behavior Chart and the Two Voices	165
	12.2 What Actions are Appropriate?	167
	12.3 Use the Measurements to Adjust the Process?	168
	12.4 The Only Reliable Basis for Extrapolation	170

PART FOUR: EXPLANATIONS

Chapter 13	How Many Digits Should You Record?	
	13.1 How the Measurement Increment Affects the Median Error	171
	13.2 The Uncertainty in the Last Digit	173
	13.3 The Twin Uncertainties Affecting Every Measurement	175
	13.4 Chunky Data and the Measurement Increment	178
	13.5 Summary	179
Chapter 14	The Basis for Manufacturing Specifications	181
	14.1 The Idea Behind Manufacturing Specifications	181
	14.2 Watershed Specifications	182
	14.3 The Bivariate Normal Model	183
	14.4 The Probability of Conforming Product	188
	14.4 Summary	193
Chapter 15	The Usefulness of Measurement Systems	195
	15.1 A Simple Experiment	195
	15.2 Detecting Shifts: How Signals Get Attenuated	201
	15.3 Detecting Shifts: The Theoretical Probabilities	203
	15.4 Attenuation of Signals from the Measurement System	206
	15.5 The Ability to Quantify Process Improvements	208
	15.6 Four Categories of Data for Process Monitoring	210
	15.7 Summary of Relative Utility	215
Chapter 16	Gauge R&R Studies	217
	16.1 A Gauge R&R Study	217
	16.2 The "Percentages" of the Total Variation	219
	16.3 The "Percentages" of the Specified Tolerance	222
	16.4 The Number of Distinct Categories	224
	16.5 The Guidelines	224
	16.6 What Can You Learn From a Gauge R&R Study?	227
	16.7 An Honest Gauge R&R Study	228
	16.8 The Basic EMP Study for the Gasket Thickness Data	232
	16.9 Alternate Estimates of Variance Components	234
	16.10 What Happens Without Any Operator Bias?	235
	16.11 Summary	237

Chapter 17	Conc	cepts and Techniques Used		239
	17.1	The Chart for Individual Values and Moving Ran	ges	239
	17.2	The Average and Range Chart		241
	17.3	Average and Range Charts with Experimental Stu	ıdies	243
	17.4	Detection Rules for Interpreting Process Behavior	Charts	245
	17.5	Bias Correction Factors		246
	17.6	Degrees of Freedom and the Coefficient of Variation	on	247
	17.7	The Analysis of Means		248
	17.8	Interval Estimates Using Student's t-Distribution		250
	17.9	For Further Reading		252
APPENDIC	ES			
Appendix 1.	Gloss	ary of Symbols	25	4-257
• •		Correction Factor Tables		
Table A.1		s Correction Factors	c_2 , c_4 , d_2 , d_3 , d_4	258
Table A.2		ng $ar{R}$ to Estimate Variances	d_2^*	259
Table A.3		ments for Range Distributions	d_2 , d_3 , d_4	260
Table A.4	Moı	ments for Distributions of the Standard Deviation	c4, c5, c6	261
Appendix 3.	Table	s for XmR Charts		
Table A.5	Deg	rees of Freedom for the Average Moving Range		262
Table A.6	Deg	rees of Freedom for the Median Moving Range		263
Appendix 4.	Table	s for Average and Range Charts		
Table A.7	Ave	erage and Range Charts based on \overline{R}	A_2, D_3, D_4, E_2	264
Table A.8	Ave	erage and Range Charts based on \widetilde{R}	A_4, D_5, D_6, E_5	265
Table A.9	Deg	rees of Freedom for the Average Range		266
Table A.10	Deg	rees of Freedom for the Median Range		267
Table A.11	Alp	ha Levels for Average Charts Used in Lieu of ANC	OM or ANOVA	268
Table A.12	Ove	erall Alpha Levels for Upper Range Limits		269

Appendix 5.	Tables for Average and Standard Deviation Charts	
Table A.13	Average and Standard Deviation Charts based on \overline{s} A_3 , B_3 , B_4	E_3 270
Table A.14	Average and Standard Deviation Charts based on \tilde{s} A_{10} , B_9 , B_{10}	
Table A.15	Degrees of Freedom for the Average Standard Deviation Statistic	272
Table A.16	Degrees of Freedom for the Median Standard Deviation Statistic	273
Appendix 6.	Tables for Range-Based Analysis of Means	
Table A.17	Analysis of Means (ANOM) 5% Critical Values	274
Table A.18	Analysis of Ranges (ANOR) 5% Critical Values	275
Table A.19 Analysis of Main Effect (ANOME) 5% Critical Values		277-279
Table A.20	Analysis of Mean Ranges (ANOMR) 5% Critical Values	280-285
Appendix 7.	Miscellaneous Tables	
Table A.21	Student's t-Distribution	286
Table A.22	Median Errors in PE Units for Different Measurement Increments	287
Table A.23	99% Interval Estimates for Percent Nonconforming in Lot	288-298
Table A.24	Truncation Effect Scaling Factors TESF	299
Table A.25	Process Three-Sigma Multipliers <i>P3SM</i>	300
Appendix 8.	Worksheets	
S	The Short EMP Study	301
H 7	The Honest Gauge R&R Study	302-304
В	The Basic EMP Study Flowchart	305
В	The Basic EMP Study Worksheet	306-311
]	Form for Average and Range Chart or ANOM Chart	312
Index		313-316